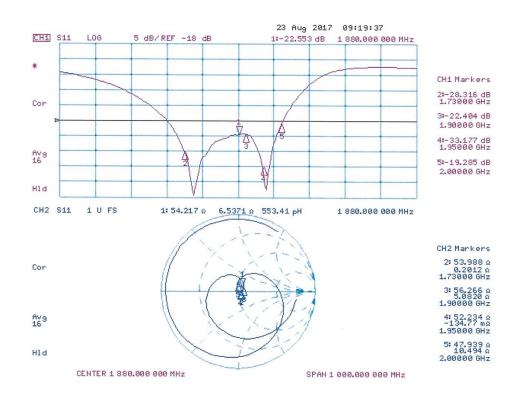


Impedance Measurement Plot



Certificate No: CD1880V3-1018_Aug17

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DASY5 H-field Result

Date: 22.08.2017

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1018

Communication System: UID 0 - CW ; Frequency: 1880 MHz Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 30.12.2016
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 13.07.2017
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.0(1446); SEMCAD X 14.6.10(7417)

Dipole H-Field measurement @ 1880MHz/H-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.4890 A/m; Power Drift = 0.02 dB

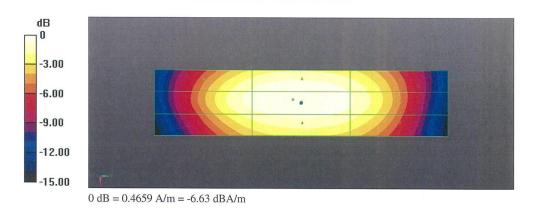
PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.4659 A/m

Near-field category: M2 (AWF 0 dB)

PMF scaled H-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
0.394 A/m	0.435 A/m	0.424 A/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
0.428 A/m	0.466 A/m	0.456 A/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
0.392 A/m	0.424 A/m	0.413 A/m



Certificate No: CD1880V3-1018_Aug17

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DASY5 E-field Result

Date: 22.08.2017

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1018

Communication System: UID 0 - CW ; Frequency: 1880 MHz Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 30.12.2016;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 13.07.2017
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.0(1446); SEMCAD X 14.6.10(7417)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 155.3 V/m; Power Drift = -0.01 dB Applied MIF = 0.00 dB RF audio interference level = 42.88 dBV/m Emission category: M1 MIF scaled E-field

Grid 1 M1	Grid 2 M1	Grid 3 M1
42.43 dBV/m	42.88 dBV/m	42.74 dBV/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
39.11 dBV/m	39.45 dBV/m	39.19 dBV/m
Grid 7 M1	Grid 8 M1	Grid 9 M1
42.22 dBV/m	42.76 dBV/m	42.65 dBV/m

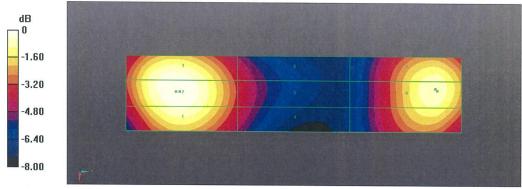
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Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 155.1 V/m; Power Drift = 0.01 dB Applied MIF = 0.00 dB RF audio interference level = 39.24 dBV/m Emission category: M2

MIF scaled E-field				
	Grid 2 M2 39.24 dBV/m	a prost of sectors		
Grid 4 M2 37.01 dBV/m	Grid 5 M2 37.16 dBV/m	Carlor Contraction Contraction		
	Grid 8 M2 38.83 dBV/m	Grid 9 M2 38.77 dBV/m		



0 dB = 139.3 V/m = 42.88 dBV/m



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Dipole 2450 MHz

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: SCS 0108

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Client **CTTL** (Auden) Certificate No: CD2450V3-1021_Aug17 **CALIBRATION CERTIFICATE** Object CD2450V3 - SN: 1021 Calibration procedure(s) QA CAL -20 V6 Calibration procedure for dipoles in air August 23, 2017 Calibration date: This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID # Cal Date (Certificate No.) Scheduled Calibration Power meter NRP SN: 104778 04-Apr-17 (No. 217-02521/02522) Apr-18 Power sensor NRP-Z91 SN: 103244 04-Apr-17 (No. 217-02521) Apr-18 Power sensor NRP-Z91 SN: 103245 04-Apr-17 (No. 217-02522) Apr-18 Reference 20 dB Attenuator SN: 5058 (20k) 07-Apr-17 (No. 217-02528) Apr-18 Type-N mismatch combination SN: 5047.2 / 06327 07-Apr-17 (No. 217-02529) Apr-18 Probe ER3DV6 SN: 2336 30-Dec-16 (No. ER3-2336_Dec16) Dec-17 Probe H3DV6 SN: 6065 30-Dec-16 (No. H3-6065_Dec16) Dec-17 DAE4 SN: 781 13-Jul-17 (No. DAE4-781_Jul17) Jul-18 Secondary Standards ID # Check Date (in house) Scheduled Check Power meter Agilent 4419B SN: GB42420191 09-Oct-09 (in house check Sep-14) In house check: Oct-17 Power sensor HP E4412A SN: US38485102 05-Jan-10 (in house check Sep-14) In house check: Oct-17 Power sensor HP 8482A SN: US37295597 09-Oct-09 (in house check Sep-14) In house check: Oct-17 RF generator R&S SMT-06 SN: 832283/011 27-Aug-12 (in house check Oct-15) In house check: Oct-17 Network Analyzer HP 8753E SN: US37390585 18-Oct-01 (in house check Oct-16) In house check: Oct-17 Name Function Signature Calibrated by: Johannes Kurikka Laboratory Technician -le Approved by: Katja Pokovic Technical Manager Issued: August 23, 2017 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: CD2450V3-1021_Aug17

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

- ANSI-C63, 19-2007 [1]
- American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
- ANSI-C63.19-2011 [2] American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm (15 mm for [2]) above the top metal edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1] and [2], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (15 mm for [2]) (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-Efield, in the plane above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: CD2450V3-1021_Aug17

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.0
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	10, 15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	2450 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 2450 MHz

H-field 10 mm above dipole surface	condition	interpolated maximum	
Maximum measured	100 mW input power	0.502 A/m ± 8.2 % (k=2)	
E-field 10 mm above dipole surface	condition		
Maximum measured above high end		Interpolated maximum	
Maximum measured above low end	100 mW input power	138.6 V/m = 42.84 dBV/m	
Averaged maximum above arm	100 mW input power	135.6 V/m = 42.64 dBV/m	
	100 mW input power	137.1 V/m ± 12.7 % (k=2)	
E-field 15 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW input power	92.0 V/m = 39.28 dBV/m	
Maximum measured above low end	100 mW input power	85.7 V/m = 38.66 dBV/m	
Averaged maximum above arm	100 mW input power	88.9 V/m ± 12.8 % (k=2)	



Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Frequency	Return Loss	Impedance
2250 MHz	17.4 dB	64.8 Ω + 4.2 jΩ
2350 MHz	29.6 dB	52.1 Ω - 2.6 jΩ
2450 MHz	27.6 dB	54.2 Ω - 1.0 jΩ
2550 MHz	31.5 dB	50.8 Ω - 2.6 jΩ
2650 MHz	18.2 dB	61.4 Ω - 7.5 ϳΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

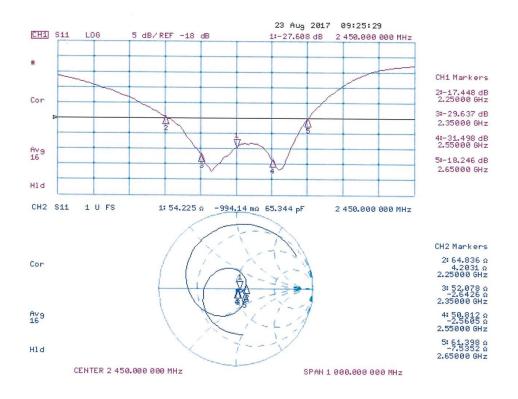
After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot



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DASY5 H-field Result

Date: 22.08.2017

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 2450 MHz; Type: CD2450V3; Serial: CD2450V3 - SN: 1021

 $\begin{array}{l} \mbox{Communication System: UID 0 - CW ; Frequency: 2450 MHz} \\ \mbox{Medium parameters used: } \sigma = 0 \mbox{S/m}, \mbox{$\epsilon_r = 1$; $\rho = 1 kg/m^3$} \\ \mbox{Phantom section: RF Section} \\ \mbox{Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)} \end{array}$

DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 30.12.2016
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 13.07.2017
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.0(1446); SEMCAD X 14.6.10(7417)

Dipole H-Field measurement @ 2450MHz/H-Scan - 2450MHz d=10mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.5270 A/m; Power Drift = -0.01 dB

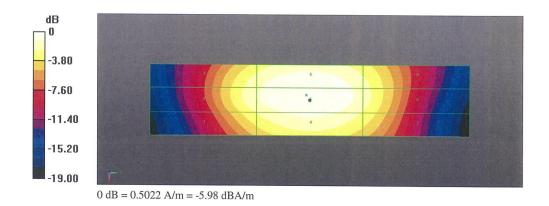
PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.5022 A/m

Near-field category: M2 (AWF 0 dB)

PMF scaled H-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
0.379 A/m	0.428 A/m	0.420 A/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
0.455 A/m	0.502 A/m	0.494 A/m
		Grid 9 M2
0.370 A/m	0.405 A/m	0.400 A/m



Certificate No: CD2450V3-1021_Aug17

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DASY5 E-field Result

Date: 22.08.2017

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 2450 MHz; Type: CD2450V3; Serial: CD2450V3 - SN: 1021

Communication System: UID 0 - CW ; Frequency: 2450 MHz Medium parameters used: $\sigma = 0$ S/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 30.12.2016;
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 13.07.2017
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.0(1446); SEMCAD X 14.6.10(7417)

Dipole E-Field measurement @ 2450MHz/E-Scan - 2450MHz d=10mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 86.46 V/m; Power Drift = 0.00 dB Applied MIF = 0.00 dB RF audio interference level = 42.84 dBV/m Emission category: M1 MIF scaled E-field

Grid 2 M1	Grid 3 M1
42.84 dBV/m	42.72 dBV/m
Grid 5 M1	Grid 6 M1
41.61 dBV/m	41.37 dBV/m
Grid 8 M1	Grid 9 M1
42.64 dBV/m	42.57 dBV/m
	42.84 dBV/m Grid 5 M1 41.61 dBV/m Grid 8 M1

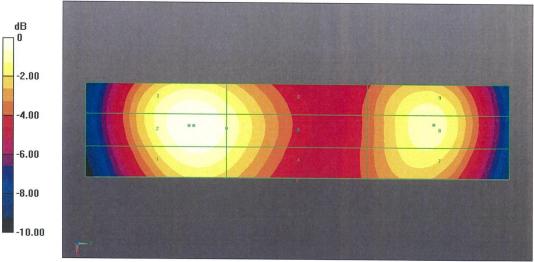
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Dipole E-Field measurement @ 2450MHz/E-Scan - 2450MHz d=15mm/Hearing Aid Compatibility Test (41x181x1): Interpolated grid: dx=0.5000 mm, dy=0.5000 mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 86.21 V/m; Power Drift = 0.02 dB Applied MIF = 0.00 dB RF audio interference level = 39.28 dBV/m Emission category: M2

MIF scaled E-field				
Grid 1 M2	Grid 2 M2	Grid 3 M2		
38.99 dBV/m	39.28 dBV/m	39.2 dBV/m		
Grid 4 M2	Grid 5 M2	Grid 6 M2		
38.53 dBV/m	38.75 dBV/m	38.64 dBV/m		
Grid 7 M2	Grid 8 M2	Grid 9 M2		
38.39 dBV/m	38.66 dBV/m	38.62 dBV/m		



0 dB = 138.6 V/m = 42.84 dBV/m



ANNEX F DAE CALIBRATION CERTIFICATE

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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Service suisse d'étalonnage
Servizio svizzero di taratura
S wiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

lient CTTL (Auden)			No: DAE4-777_Sep17
CALIBRATION C	ERTIFICATE		
Dbject	DAE4 - SD 000 D	04 BM - SN: 777	
Calibration procedure(s)	QA CAL-06.v29 Calibration procec	lure for the data acquisition ele	ectronics (DAE)
alibration date:	September 08, 20	17	
The measurements and the unce	rtainties with confidence pro	nal standards, which realize the physical bability are given on the following pages facility: environment temperature (22 ± 3	and are part of the certificate.
alibration Equipment used (M&T	TE critical for calibration)		
rimary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
eithley Multimeter Type 2001	SN: 0810278	31-Aug-17 (No:21092)	Aug-18
econdary Standards	ID #	Check Date (in house)	Scheduled Check
uto DAE Calibration Unit	SE UWS 053 AA 1001		In house check: Jan-18
alibrator Box V2.1	SE UMS 006 AA 1002	05-Jan-17 (in house check)	In house check: Jan-18
	Name	Function	Signature
alibrated by:	Name Dominique Steffen	Function Laboratory Technician	Signature
			Signature
alibrated by: pproved by:	Dominique Steffen	Laboratory Technician	Signature

Certificate No: DAE4-777_Sep17

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Accreditation No.: SCS 0108

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Glossary DAE

data acquisition electronics Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE4-777 Sep17

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DC Voltage Measurement

A/D - Converter Reso	lution nominal			
High Range:	1LSB =	6.1μV ,	full range =	-100+300 mV
Low Range:	1LSB =	61nV,	full range =	-1+3mV
DASY measurement	parameters: Aut	o Zero Time: 3	sec; Measuring	time: 3 sec

Calibration Factors	X	Y	Z
High Range	405.400 ± 0.02% (k=2)	405.869 ± 0.02% (k=2)	405.579 ± 0.02% (k=2)
Low Range	3.96640 ± 1.50% (k=2)	3.96264 ± 1.50% (k=2)	4.00499 ± 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	97.0°±1°
	01.0 11

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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range		Reading (µV)	Difference (µV)	Error (%)
Channel X	+ Input	200022.73	-12.42	-0.01
Channel X	+ Input	20003.49	-1.25	-0.01
Channel X	- Input	-19998.82	6.77	-0.03
Channel Y	+ Input	200025.10	-10.04	-0.01
Channel Y	+ Input	20007.22	2.54	0.01
Channel Y	- Input	-20002.34	3.30	-0.02
Channel Z	+ Input	200028.10	-6.82	-0.00
Channel Z	+ Input	20002.36	-2.19	-0.01
Channel Z	~ Input	-20003.64	2.12	-0.01

Low Range	Reading (μV)	Difference (µV)	Error (%)
Channel X + Input	2000.54	-0.37	-0.02
Channel X + Input	201.37	0.50	0.25
Channel X - Input	-199.19	-0.20	0.10
Channel Y + Input	1999.95	-0.89	-0.04
Channel Y + Input	200.04	-0.75	-0.37
Channel Y - Input	-199.96	-0.85	0.43
Channel Z + Input	2001.05	0.20	0.01
Channel Z + Input	199.88	-0.86	-0.43
Channel Z - Input	-200.02	-0.88	0.44
		and the second s	

2. Common mode sensitivity DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	5.45	3.79
	- 200	3.93	0.83
Channel Y	200	7.70	7.39
	- 200	-9.52	-8.90
Channel Z	200	7.51	6.49
	- 200	-9.21	-8.71

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (µV)	Channel Z (µV)
Channel X	200	-	-1.61	-2.84
Channel Y	200	8.30	-	0.46
Channel Z	200	6.69	5.02	_

Certificate No: DAE4-777_Sep17



4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15919	14652
Channel Y	16343	14477
Channel Z	16033	14911

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec input 10 M\Omega $\,$

	Average (µV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	-0.50	-2.04	0.95	0.51
Channel Y	1.56	0.40	2.80	0.48
Channel Z	0.26	-0.78	1.16	0.42

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC) +7.9	
Supply (+ Vcc)		
Supply (- Vcc)	-7.6	

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

Certificate No: DAE4-777_Sep17

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The photos of HAC test are presented in the additional document:

Appendix to test report No.I18Z60479-SEM04/05

The photos of HAC test